

<b>Notice of References Cited</b>	Application/Control No. 10/623,202	Applicant(s)/Patent Under Reexamination HOFFMANN ET AL.	
	Examiner Tran N. Nguyen	Art Unit 2834	Page 1 of 1

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	C	US-6,020,664	02-2000	Liu et al.	310/90
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	M	US-			

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**NON-PATENT DOCUMENTS**

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